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FEATRLRES

- Excellent solderability and high heat resistance.
- Excellent terminal strength construction.
- Packed in embossed carrier tape and can be used by automatic mounting machine.
- 100% Lead(Pb) & Halogen-Free and RoHS compliant.

CONFIGRLRATIONS & DIMENSIONS (unit in mm)

AR7 0 MARKING

Size	Α	В	С	L	G	Н
HSDR75	7.80±0.3	7.00±0.3	5.00±0.3	8.0	2.0	7.5

ELECTRICAL CHARACTERISTICS

Dout Number	Inductance (uH)	Tolerance (%)	Test Frequency	DCR	IDC
Part Number			(Hz)	(Ω) max.	(A) max.
HSDR75-3R3M	3.30	± 20%	1V/7.96M	0.03	4.60
HSDR75-4R7M	4.70	± 20%	1V/7.96M	0.04	4.20
HSDR75-100M	10.0	± 20%	1V/2.52M	0.07	2.30
HSDR75-120M	12.0	± 20%	1V/2.52M	0.08	2.00
HSDR75-150M	15.0	± 20%	1V/2.52M	0.09	1.80
HSDR75-180M	18.0	± 20%	1V/2.52M	0.10	1.60
HSDR75-220M	22.0	± 20%	1V/2.52M	0.11	1.50
HSDR75-270M	27.0	± 20%	1V/2.52M	0.12	1.30
HSDR75-330M	33.0	± 20%	1V/2.52M	0.13	1.20
HSDR75-390M	39.0	± 20%	1V/2.52M	0.16	1.10
HSDR75-470K	47.0	± 10%	1V/2.52M	0.18	1.10
HSDR75-560K	56.0	± 10%	1V/2.52M	0.24	0.94

Recommended Land pattern



SA-SP-001

HSDR75-680K	68.0	± 10%	1V/2.52M	0.28	0.85
HSDR75-820K	82.0	± 10%	1V/2.52M	0.37	0.78
HSDR75-101K	100	± 10%	1V/1K	0.43	0.72
HSDR75-121K	120	± 10%	1V/1K	0.47	0.66
HSDR75-151K	150	± 10%	1V/1K	0.64	0.58
HSDR75-181K	180	± 10%	1V/1K	0.71	0.51
HSDR75-221K	220	± 10%	1V/1K	0.96	0.49
HSDR75-391K	390	± 10%	1V/1K	1.77	0.36
HSDR75-471K	470	± 10%	1V/1K	1.96	0.34

Note:

Based on inductance change $(\triangle L/L0 : \leq -35\%)$ @ ambient temp. 25% Based on temperature rise $(\triangle T : 40\%$ typ.)

Reliability and Test Condition

Item	Performance	Test Condition		
Operating temperature	-40~+125°C (Including self - temperature rise)			
Storage temperature	110~+40℃,50~60%RH (Product with taping) 240~+125℃ (on board)			
Electrical Performance Test				
Inductance	Refer to standard electrical characteristics list.	HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter.		
DCR		CH16502, Agilent 33420A Micro-Ohm Meter.		
Saturation Current (Isat)	Approximately_L30%	Saturation DC Current (Isat) will cause L0 to drop _∆L(%)		
Heat Rated Current (Irms)	Approximately △T40°C	Heat Rated Current (Irms) will cause the coil temperature rise $\triangle T(\mathbb{C})$. 1.Applied the allowed DC current 2.Temperature measured by digital surface thermometer		
Reliability Test				
Life Test		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles) Temperature : 125±2°C (Inductor) Applied current : rated current Duration : 1000±12hrs Measured at room temperature after placing for 24±2 hrs		
Load Humidity	Appearance:No damage.	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Humidity : 85±2 × R.H, Temperature : 85℃±2℃ Duration : 1000hrs Min. with 100% rated current Measured at room temperature after placing for 24±2 hrs		
Moisture Resistance	Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	 Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles 1. Baked at50℃ for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to 65±2℃ 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25℃ in 2.5hrs. 3. Raise temperature to 65±2℃ 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25℃ in 2.5hrs, keep at 25℃ for 2 hrs then keep at -10℃ for 3 hrs 4. Keep at 25℃ 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1~2 hrs. 		



Thermal shock Vibration		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD- 020DClassification Reflow Profiles Condition for 1 cycle Step1 : $-40\pm2^{\circ}$ 30 \pm 5min Step2 : $25\pm2^{\circ}$ \leq 0.5min Step3 : $125\pm2^{\circ}$ \leq 0.5min Number of cycles : 500 Measured at room temperature after placing for 24 \pm 2 hrs Oscillation Frequency: 10 ~ 2K ~ 10Hz for 20 minutes
		Equipment : Vibration checker Total Amplitude:1.52mm±10% Testing Time : 12 hours(20 minutes, 12 cycles each of 3 orientations).
Bending		Shall be mounted on a FR4 substrate of the following dimensions: >=0805 inch(2012mm):40x100x1.2mm <0805 inch(2012mm):40x100x0.8mm Bending depth: >=0805 inch(2012mm):1.2mm <0805 inch(2012mm):0.8mm duration of 10 sec.
Shock	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value.	Type Peak value (g's) Normal duration (D) (ms) Wave form Velocity change (Vi)ft/sec
	RDC : within \pm 15% of initial value and shall not exceed the specification value	SMD 50 11 Half-sine 11.3 Lead 50 11 Half-sine 11.3
Solder ability	More than 95% of the terminal electrode should be covered with solder。	Preheat: 150°C,60sec Solder: Sn96.5% Ag3% Cu0.5% Temperature: 245±5°C ∘ Flux for lead free: Rosin. 9.5% ∘ Dip time: 4±1sec ∘ Depth: completely cover the termination Depth: completely cover the termination
Resistance to Soldering Heat		Temperature (°C) Time(s) Temperature ramp/immersion and emersion rate Number of heat cycles 260 ±5 (solder temp) 10 ±1 25mm/s ±6 mm/s 1
Terminal Strength	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value e	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD- 020DClassification Reflow Profiles With the component mounted on a PCB with the device to be tested, apply a force/0805/18(g, <=0805/5.05kg)to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested.

Note : When there are questions concerning measurement result : measurement shall be made after 48 ± 2 hours of recovery under the standard condition.